


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/735,181	NISHIMURA ET AL.	
	Examiner	Art Unit	
	Luan K. Bui	3728	

SEARCHED			
Class	Subclass	Date	Examiner
206	528, 530	11/4/2005	LKB
	534		
	534.1		
	534.2		
	538, 539		
	484		
	484.2		
428	34.7		
	35.2		
ABOVE UPDATED		12/1/06	
53	133.8		
	912		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR